

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

217363US3

SERIAL NO.

NEW APPLICATION

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Eisaku ITO, et al.

FILING DATE

HEREWITH

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
W	AO	5-222901	08/31/93	JAPAN (with English Abstract)		X
W	AP	11-247615	09/14/99	JAPAN (with English Abstract)		X
W	AQ	10-196303	07/28/98	JAPAN (with English Abstract)		X
W	AR	2000-257447	09/19/00	JAPAN (with English Abstract)		X
W	AS	2000-179303	06/27/00	JAPAN (with English Abstract)		X
W	AT	2710729	10/24/97	JAPAN (Partial English Abstract)		X
W	AU	10-274003	10/13/98	JAPAN (With English Abstract)		X
W	AV	11-336506	12/07/99	JAPAN (With English Abstract)		X

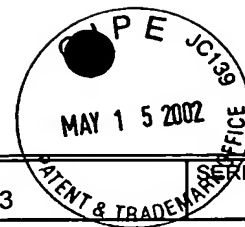
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner *Verdier*Date Considered *1-24-04*

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

JCT60 U.S. PTO
 10/022770
 12/20/01



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217363US3		SERIAL NO. 10/022,770	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Eisaku ITO, et al.			
				FILING DATE December 20, 2001		GROUP 3746	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
W	AO	584 884	02/17/25	FRANCE			X
W	AP	196 12 394	10/02/97	GERMANY			X
W	AQ	58-20903	02/07/83	JAPAN (with English Abstract)			X
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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	AZ						
Examiner <i>Verdew</i>					Date Considered <i>1-29-04</i>		
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